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			FILING January 3, 2002 GROUP			1762			
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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE .		NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
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	-6,096,425	08/01/00	-Smith-		428	412			
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	DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO		
200	47-22475	-06/23/72	-Japan			7	Abstract only		
	04249146	09/04/92	Japan				/ Abstract		
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830	07151914	-06/16/95	-Japan	the same of the sa		The state of the s	Abstract		
	OTHER DOCUM	ENTS (Includin	a Author.	Title, Date, Pertir	nent Pages, Etc.)				
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Form PTO-A820 (also form PTO-1449)

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Application Number

FORM PTO-1449	ATTY. DOCKET NO.	SERIAL NO.	
	07K8-101934	110/037.673	
PLEST OF PATENTS AND OTHER ITEMS FOR APPLICANT'S	APPLICANT:		
INFORMATION DISCLOSURE STATEMENT	Igor Loshak, et al.		

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Igor Loshak, et al.

FILING DATE:

January 3, 2002

GROUP:

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